SCES490C - SEPTEMBER 2003 - REVISED JANUARY 2008

<ul> <li>Qualified for Automotive Applications</li> <li>ESD Protection Exceeds 2000 V Per</li> </ul>	D OR PW PACKAGE (TOP VIEW)						
MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)	$\begin{array}{c c} 1A \begin{bmatrix} 1 & 14 \end{bmatrix} V_{CC} \\ 1B \begin{bmatrix} 12 & 13 \end{bmatrix} 4B \end{array}$						
<ul> <li>Operates From 1.65 V to 3.6 V</li> </ul>	1B [ 2 13 ] 4B 1Y [ 3 12 ] 4A						
<ul> <li>Max t<sub>pd</sub> of 3 ns at 3.3 V</li> </ul>	2A 🛛 4 11 🗍 4Y						
<ul> <li>±24-mA Output Drive at 3.3 V</li> </ul>	2B 🛛 5 10 🗍 3B						
<ul> <li>Latch-Up Performance Exceeds 250 mA Per JESD 17</li> </ul>	2Y [[6 9]] 3A GND [[7 8]] 3Y						

#### description/ordering informatiom

The SN74ALVC00 quadruple 2-input positive-NAND gate is designed for 1.65-V to 3.6-V V<sub>CC</sub> operation. The device performs the Boolean function  $Y = \overline{A \cdot B}$  or  $Y = \overline{A + B}$  in positive logic.

# 

TA	PACK	AGE <sup>‡</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
1000 10 0500	SOIC – D	Tape and reel	SN74ALVC00IDRQ1	ALVC00I
–40°C to 85°C	TSSOP – PW	Tape and reel	SN74ALVC00IPWRQ1	VA00I

<sup>†</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

<sup>‡</sup> Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

FUNCTION TABLE (each gate)									
INP	UTS	OUTPUT							
Α	В	Y	l						
Н	Н	L							
L	Х	н	1						
Х	L	н	l						

logic diagram, each gate (positive logic)





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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	–0.5 V to 4.6 V
Input voltage range, V <sub>I</sub> (see Note 1)	
Output voltage range, V <sub>O</sub> (see Notes 1 and 2)	-0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–50 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	
Continuous output current, I <sub>O</sub>	±50 mA
Continuous current through V <sub>CC</sub> or GND	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3): D package	
PW package	113°C/W
Storage temperature range, T <sub>stg</sub>	
tresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the c	device. These are stress ratings only, and

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. This value is limited to 4.6 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.

#### recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		1.65	3.6	V
		V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65 \times V_{CC}$		
V <sub>IH</sub>	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	2		
		V <sub>CC</sub> = 1.65 V to 1.95 V		$0.35 \times V_{CC}$	
VIL	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V
		V <sub>CC</sub> = 2.7 V to 3.6 V		0.8	
VI	Input voltage		0	3.6	V
Vo	Output voltage		0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 1.65 V		-4	
		V <sub>CC</sub> = 2.3 V		-12	
I <sub>ОН</sub>	High-level output current	$V_{CC} = 2.7 V$		-12	mA
		$V_{CC} = 3 V$		-24	
		V <sub>CC</sub> = 1.65 V		4	
		V <sub>CC</sub> = 2.3 V		12	
I <sub>OL</sub>	Low-level output current	$V_{CC} = 2.7 V$		12	mA
		$V_{CC} = 3 V$		24	
$\Delta t/\Delta v$	Input transition rise or fall rate			5	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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PARAMETER	TEST COND	ITIONS	v <sub>cc</sub>	MIN	TYP <sup>†</sup>	МАХ	UNIT
	I <sub>OH</sub> = -100 μA		1.65 V to 3.6 V	V <sub>CC</sub> -0.2	2		
	$I_{OH} = -4 \text{ mA}$		1.65 V	1.2			
	I <sub>OH</sub> = -6 mA		2.3 V	2			
V <sub>OH</sub> I V <sub>OH</sub> I I I I I I I I I I I I I			2.3 V	1.7			V
	I <sub>OH</sub> = -12 mA		2.7 V	2.2			
			3 V	2.4			
	I <sub>OH</sub> = -24 mA		3 V	2			
$V_{OH} = -100 \ \mu A$ $I_{OH} = -4 \ mA$ $I_{OH} = -6 \ mA$ $I_{OH} = -6 \ mA$ $I_{OH} = -12 \ mA$ $I_{OH} = -24 \ mA$ $I_{OL} = -24 \ mA$ $I_{OL} = 4 \ mA$ $I_{OL} = 4 \ mA$ $I_{OL} = 6 \ mA$ $I_{OL} = 12 \ mA$ $I_{OL} = 12 \ mA$ $I_{OL} = 24 \ mA$ $I_{OL} = 12 \ mA$ $I_{OL} =$	I <sub>OL</sub> = 100 μA		1.65 V to 3.6 V			0.2	
	I <sub>OL</sub> = 4 mA		1.65 V			0.45	
	I <sub>OL</sub> = 6 mA		2.3 V			0.4	
			2.3 V			0.7	V
	$I_{OL} = 12 \text{ mA}$		2.7 V			0.4	
	I <sub>OL</sub> = 24 mA		3 V			0.55	
Ц	$V_{I} = V_{CC}$ or GND		3.6 V			±5	μA
I <sub>CC</sub>	$V_{I} = V_{CC}$ or GND, $I_{C}$	<sub>D</sub> = 0	3.6 V			10	μA
	One input at V <sub>CC</sub> – 0.6 V, C	Other inputs at V <sub>CC</sub> or GND	3 V to 3.6 V			750	μA
	$V_{I} = V_{CC}$ or GND		3.3 V		4.5		pF

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

<sup>†</sup> All typical values are at  $V_{CC} = 3.3$  V,  $T_A = 25^{\circ}$ C.

# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO (INPUT) (OUTPUT)		V <sub>CC</sub> = 1.8 V ± 0.15 V		$V_{CC}$ = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
	(INPUT)	(001901)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	A or B	Y	1	4.4	1	2.8		3.2	0.5	3	ns

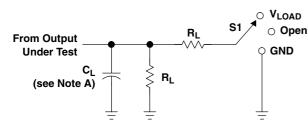
#### operating characteristics, $T_A = 25^{\circ}C$

PARAMETER				V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V	V <sub>CC</sub> = 3.3 V	
	FARAMEIER	IESI C	ONDITIONS	ТҮР	ТҮР	ТҮР	UNIT
Cp	Power dissipation capacitance per gate	$C_L = 0,$	f = 10 MHz	20	21	23	pF



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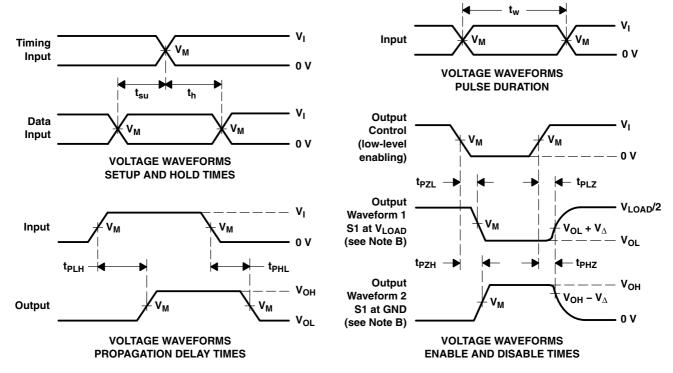




LOAD CIRCUIT

TEST	S1
t <sub>pd</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

Γ	V	INPUT		V	V	•	-	
	V <sub>CC</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	C∟	RL	$V_{\Delta}$
Γ	1.8 V $\pm$ 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	<b>1 k</b> Ω	0.15 V
	$\textbf{2.5}\pm\textbf{0.2}~\textbf{V}$	V <sub>cc</sub>	≤2 ns	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	<b>500</b> Ω	0.15 V
	2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V
	3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V



NOTES: A. C<sub>1</sub> includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω.

- C. All input pulses are supplied by generators having the following characteristics: PRH  $\leq$  10 MHz,  $z_0 = 50$
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.







10-Dec-2020

#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	e Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ALVC00IPWRG4Q1	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVC00I	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(<sup>6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN74ALVC00-Q1 :



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### PACKAGE OPTION ADDENDUM

10-Dec-2020

#### Catalog: SN74ALVC00

• Enhanced Product: SN74ALVC00-EP

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications

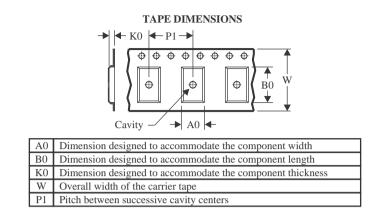


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#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALVC00IPWRG4Q1	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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# PACKAGE MATERIALS INFORMATION

3-Jun-2022



*All	dimensions	are	nominal
------	------------	-----	---------

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALVC00IPWRG4Q1	TSSOP	PW	14	2000	356.0	356.0	35.0

# **PW0014A**



# **PACKAGE OUTLINE**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



### PW0014A

# **EXAMPLE BOARD LAYOUT**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



### PW0014A

# **EXAMPLE STENCIL DESIGN**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



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